

LM709 Operational Amplifier

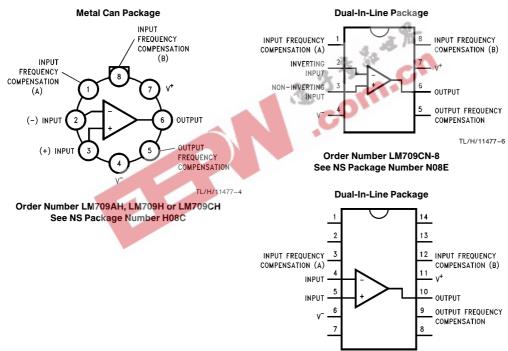
General Description

The LM709 series is a monolithic operational amplifier intended for general-purpose applications. Operation is completely specified over the range of voltages commonly used for these devices. The design, in addition to providing high gain, minimizes both offset voltage and bias currents. Further, the class-B output stage gives a large output capability with minimum power drain.

External components are used to frequency compensate the amplifier. Although the unity-gain compensation network specified will make the amplifier unconditionally stable in all feedback configurations, compensation can be tailored to optimize high-frequency performance for any gain setting.

The LM709C is the commercial-industrial version of the LM709. It is identical to the LM709 except that it is specified for operation from 0°C to +70°C.

Connection Diagrams



Order Number LM709CN See NS Package Number N14A

TI /H/11477-5

Absolute Maximum Ratings (Note 3)

If Military/Aerospace specified devices are required, please contact the National Semiconductor Sales Office/Distributors for availability and specifications.

Supply Voltage

LM709/LM709A/LM709C

Power Dissipation (Note 1)

LM709/LM709A

LM709C

Differential Input Voltage

LM709/LM709A/LM709C

Input Voltage

LM709/LM709A/LM709C

Output Short-Circuit Duration ($T_A = +25$ °C)

LM709/LM709A/LM709C

5 seconds

300 mW

250 mW

 $\pm\,5V$

±10V

Storage Temperature Range

LM709/LM709A/LM709C

-65°C to +150°C

Lead Temperature (Soldering, 10 sec.) LM709/LM709A/LM709C

300°C

Operating Ratings (Note 3)

Junction Temperature Range (Note 1)

LM709/LM709A

-55°C to +150°C LM709C

 $0^{\circ}C$ to $+100^{\circ}C$

Thermal Resistance (θ_{JA})

H Package

150°C/W, (θ_{JC}) 45°C/W 134°C/W

8-Pin N Package

109°C/W

14-Pin N Package

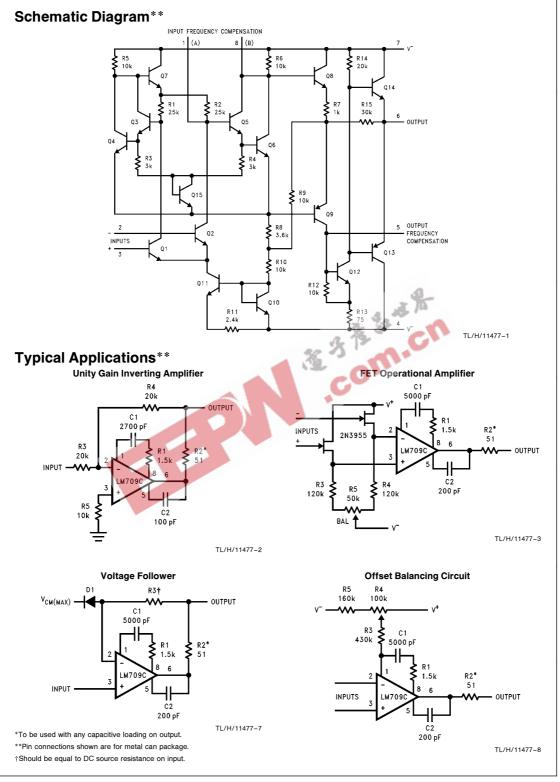
Electrical Characteristics (Note 2)

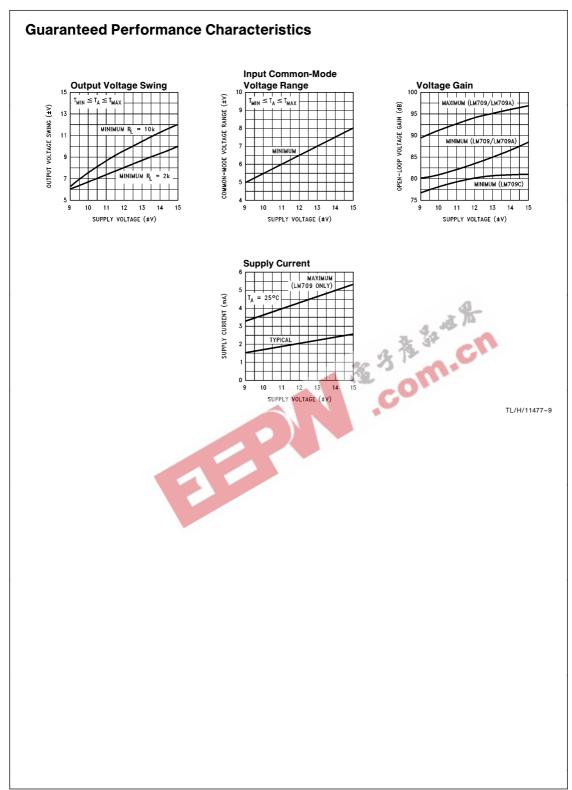
Parameter	Conditions	LM709A			LM709			LM709C			
		Min	Тур	Max	Min	Тур	Max	Min	Тур	Max	Units
Input Offset Voltage	$T_A=$ 25°C, $R_S\leq$ 10 k Ω		0.6	2.0		1.0	5.0		2.0	7.5	mV
Input Bias Current	$T_A = 25^{\circ}C$		100	200		200	500	A	300	1500	nA
Input Offset Current	$T_A = 25^{\circ}C$		10	50		50	200	27	100	500	nA
Input Resistance	$T_A = 25^{\circ}C$	350	700		150	400	34	50	250		kΩ
Output Resistance	$T_A = 25^{\circ}C$		150		€3	150	-	C	150		Ω
Supply Current	$T_A = 25^{\circ}C, V_S = \pm 15V$		2.5	3.6	6	2.6	5.5	1	2.6	6.6	mA
Transient Response Risetime Overshoot	$V_{IN} = 20$ mV, $C_L \le 100$ pF $T_A = 25^{\circ}C$		1	1.5 30		0 .3	1.0 30		0.3 10	1.0 30	μs %
Slew Rate	$T_A = 25^{\circ}C$	-)	0.25			0.25			0.25		V/μs
Input Offset Voltage	$R_S \le 10 \text{ k}\Omega$	Δ		3.0			6.0			10	mV
Average Temperature Coefficient of Input Offset Voltage	$\begin{split} R_S = 50\Omega & T_A = 25^\circ\text{C to }T_{\text{MAX}} \\ T_A = 25^\circ\text{C to }T_{\text{MIN}} \\ R_S = 10\text{k}\Omega & T_A = 25^\circ\text{C to }T_{\text{MAX}} \\ T_A = 25^\circ\text{C to }T_{\text{MIN}} \end{split}$		1.8 1.8 2.0 4.8	10 10 15 25		3.0 6.0			6.0 12		μV/°C
Large Signal Voltage Gain	$V_S = \pm 15V, R_L \ge 2 \text{ k}\Omega$ $V_{OUT} = \pm 10V$	25		70	25	45	70	15	45		V/mV
Output Voltage Swing	$\begin{aligned} V_S &= \pm 15 V, R_L = 10 k\Omega \\ V_S &= \pm 15 V, R_L = 2 k\Omega \end{aligned}$	±12 ±10	±14 ±13		±12 ±10	±14 ±13		±12 ±10	±14 ±13		٧
Input Voltage Range	$V_S = \pm 15V$	±8			±8	±10		±8	±10		٧
Common-Mode Rejection Ratio	$R_{S} \leq$ 10 k Ω	80	110		70	90		65	90		dB
Supply Voltage Rejection Ratio	$R_S \le 10 \text{ k}\Omega$		40	100		25	150		25	200	μV/V
Input Offset Current	$\begin{aligned} T_{A} &= T_{MAX} \\ T_{A} &= T_{MIN} \end{aligned}$		3.5 40	50 250		20 100	200 500		75 125	400 750	nA
Input Bias Current	$T_A = T_{MIN}$		0.3	0.6		0.5	1.5		0.36	2.0	μΑ
Input Resistance	$T_A = T_{MIN}$	85	170		40	100		50	250		kΩ

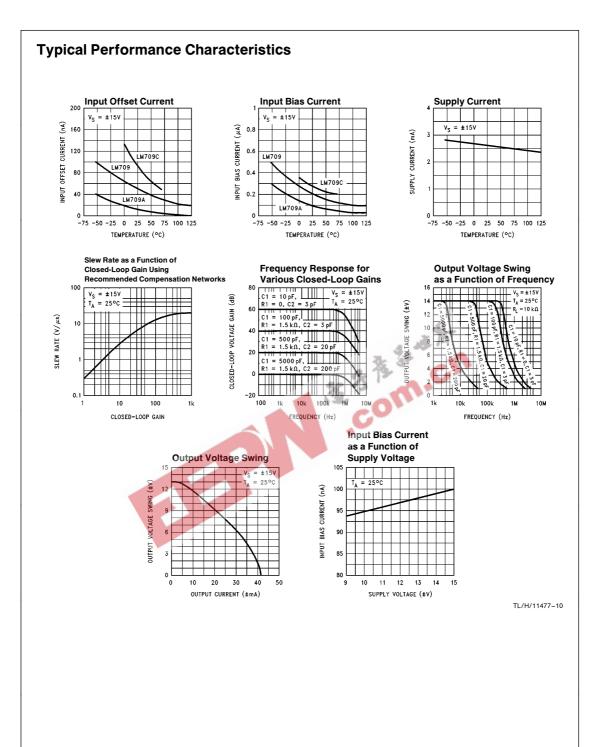
Note 1: For operating at elevated temperatures, the device must be derated based on a 150°C maximum junction temperature for LM709/LM709A and 100°C maximum for L709C. For operating at elevated temperatures, the device must be derated based on thermal resistance θ_{JA} , $T_{J(MAX)}$ and T_{A} .

Note 2: These specifications apply for $-55^{\circ}C \le T_A \le +125^{\circ}C$ for the LM709/LM709A and $0^{\circ}C \le T_A \le +70^{\circ}C$ for the LM709C with the following conditions: $\pm 9V \le V_S \le \pm 15V$, C1 = 5000 pF, R1 = 1.5 k Ω , C2 = 200 pF and R2 = 51 Ω .

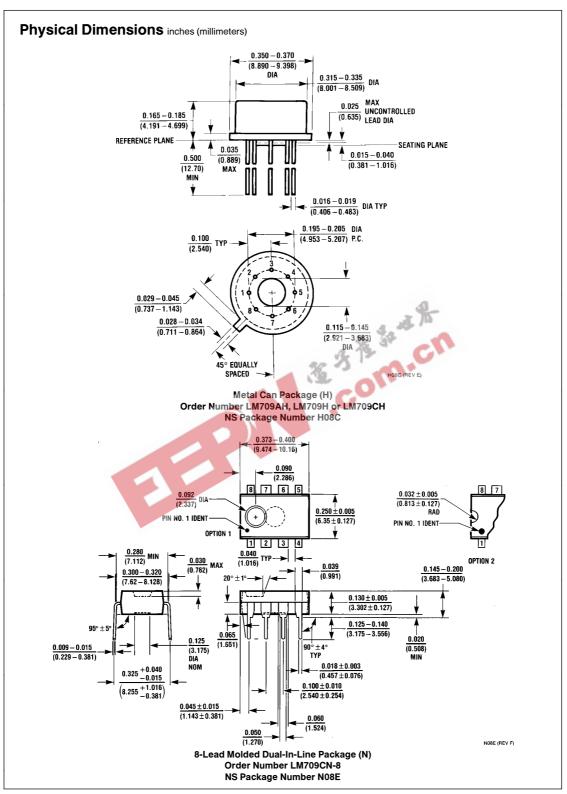
Note 3: Absolute Maximum Ratings indicate limits which if exceeded may result in damage. Operating Ratings are conditions where the device is expected to be functional but not necessarily within the guaranteed performance limits. For guaranteed specifications and test conditions, see the Electrical Characteristics.











Physical Dimensions inches (millimeters) (Continued) $\frac{0.740 - 0.770}{(18.80 - 19.56)}$ 14 13 12 14 13 12 11 10 9 8 $\frac{0.250 \pm 0.010}{(6.350 \pm 0.254)}$ PIN NO. 1 1 2 3 4 5 6 7 $\frac{0.092}{(2.337)}$ DIA $\frac{0.030}{(0.762)}$ MAX OPTION 1 OPTION 02 0.300 - 0.320 (7.620 - 8.128) 0.065 (1.651) $\frac{0.145 - 0.200}{(3.683 - 5.080)}$ $\frac{0.060}{(1.524)}$ TYP * 0.008 - 0.016 (0.203 - 0.406) TYP 0.125 - 0.150 (3.175 - 3.810) 0.280 (7.112) MIN $\frac{0.014-0.023}{(0.356-0.584)}\,\mathrm{TYP}$ 0.100 ± 0.010 (2.540 ± 0.254) TYP $0.325 { +0.040 \atop -0.015 \atop -0.015 \atop (8.255 { +1.016 \atop -0.381})}$ 14-Lead Molded Dual-In-Line Package (N) Order Number LM709CN NS Package Number N14A

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